Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/734,245	NIHEI ET AL.
Examiner	Art Unit

Christopher P. Schwartz

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Class	Subclass	Date	Examiner
701	70	9/21/2006	CPS
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TMI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
303	allabove	9/21/2006	CPS		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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